



**ZMM55B Series**

# Zener diode

## Features

High reliability



## Applications

Voltage stabilization

## Construction

Silicon epitaxial planar

## Absolute Maximum Ratings

$T_j=25^\circ\text{C}$

Parameter	Test Conditions	Type	Symbol	Value	Unit
Power dissipation	$I=4\text{mm } T_L \leq 25^\circ\text{C}$		$P_V$	500	mW
Z-current			$I_Z$	$P_V/V_Z$	mA
Junction temperature			$T_j$	175	°C
Storage temperature range			$T_{stg}$	-65~+175	°C

## Maximum Thermal Resistance

$T_j=25^\circ\text{C}$

Parameter	Test Conditions	Symbol	Value	Unit
Junction ambient	$I=4\text{mm } T_L=\text{constant}$	$R_{thJA}$	350	K/W

## Electrical Characteristics

$T_j=25^\circ\text{C}$

Parameter	Test Conditions	Type	Symbol	Min	Typ	Max	Unit
Forward voltage	$I_F=200\text{mA}$		$V_F$		1.5		V



## ZMM55B Series

Type	V <sub>Znom</sub>	I <sub>ZT</sub> for V <sub>ZT</sub> and	r <sub>zT</sub>	r <sub>zK</sub> at I <sub>zK</sub>	I <sub>R</sub> and	I <sub>R</sub> at V <sub>R</sub>	T <sub>KVZ</sub>			
ZMM55B	V	mA	V <sup>1)</sup>	Ω	Ω	mA	μA	μA <sup>2)</sup>	V	%/K
2V4	2.4	5	2.35~2.44	<85	<600	1	<50	<100	1	-0.09~-0.06
2V7	2.7	5	2.6~2.8	<85	<600	1	<10	<50	1	-0.09~-0.06
3V0	3	5	2.9~3.1	<85	<600	1	<4	<40	1	-0.08~-0.05
3V3	3.3	5	3.2~3.4	<85	<600	1	<2	<40	1	-0.08~-0.05
3V6	3.6	5	3.5~3.7	<85	<600	1	<2	<40	1	-0.08~-0.05
3V9	3.9	5	3.8~4.0	<85	<600	1	<2	<40	1	-0.08~-0.05
4V3	4.3	5	4.2~4.4	<75	<600	1	<1	<20	1	-0.06~-0.03
4V7	4.7	5	4.6~4.8	<60	<600	1	<0.5	<10	1	-0.05~+0.02
5V1	5.1	5	5.0~5.2	<35	<550	1	<0.1	<2	1	-0.02~+0.02
5V6	5.6	5	5.5~5.7	<25	<450	1	<0.1	<2	1	-0.05~+0.05
6V2	6.2	5	6.1~6.3	<10	<200	1	<0.1	<2	2	0.03~0.06
6V8	6.8	5	6.7~6.9	<8	<150	1	<0.1	<2	3	0.03~0.07
7V5	7.5	5	7.4~7.7	<7	<50	1	<0.1	<2	5	0.03~0.07
8V2	8.2	5	8.0~8.4	<7	<50	1	<0.1	<2	6.2	0.03~0.08
9V1	9.1	5	8.9~9.3	<10	<50	1	<0.1	<2	6.8	0.03~0.09
10	10	5	9.8~10.2	<15	<70	1	<0.1	<2	7.5	0.03~0.1
11	11	5	10.8~11.2	<20	<70	1	<0.1	<2	8.2	0.03~0.11
12	12	5	11.8~12.2	<20	<90	1	<0.1	<2	9.1	0.03~0.11
13	13	5	12.7~13.3	<26	<110	1	<0.1	<2	10	0.03~0.11
15	15	5	14.7~15.3	<30	<110	1	<0.1	<2	11	0.03~0.11
16	16	5	15.7~16.3	<40	<170	1	<0.1	<2	12	0.03~0.11
18	18	5	17.6~18.4	<50	<170	1	<0.1	<2	13	0.03~0.11
20	20	5	19.6~20.4	<55	<220	1	<0.1	<2	15	0.03~0.11
22	22	5	21.6~22.4	<55	<220	1	<0.1	<2	16	0.04~0.12
24	24	5	23.5~24.5	<80	<220	1	<0.1	<2	18	0.04~0.12
27	27	5	26.5~27.5	<80	<220	1	<0.1	<2	20	0.04~0.12
30	30	5	29.4~30.6	<80	<220	1	<0.1	<2	22	0.04~0.12
33	33	5	32.3~33.7	<80	<220	1	<0.1	<2	24	0.04~0.12
36	36	5	35.3~36.7	<80	<220	1	<0.1	<2	27	0.04~0.12

<sup>1)</sup> Tighter tolerances available request:

ZMM55A... ±1% of V<sub>Znom</sub>

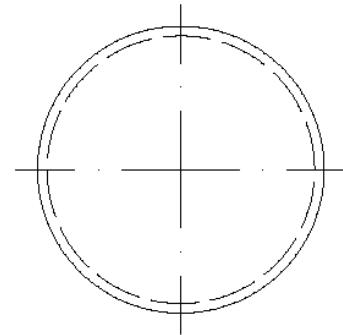
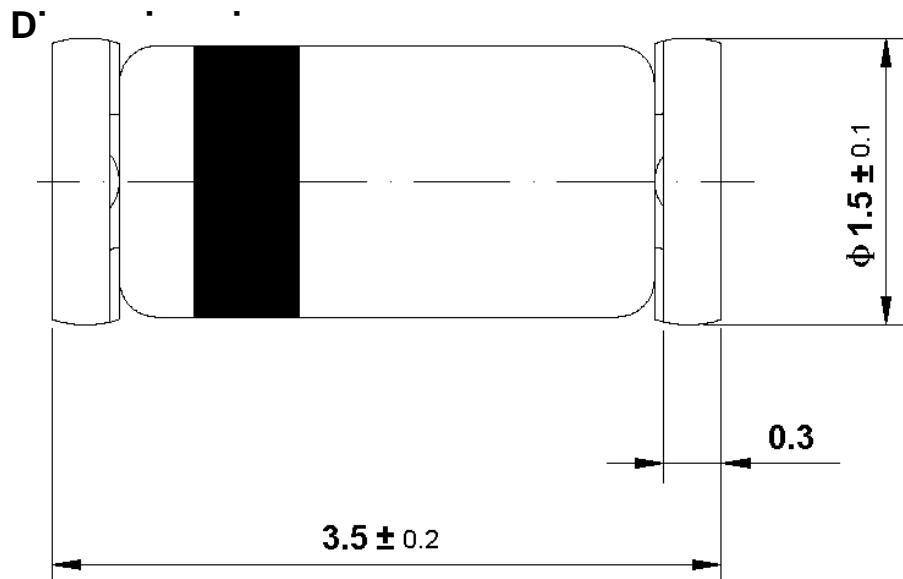
ZMM55C... ±5% of V<sub>Znom</sub>

<sup>2)</sup> at T<sub>j</sub>=150°C



## BZX55B Series

### ZMM55C Series



#### Dimensions in mm

Standard Glass Case  
JEDEC LL34

**Characteristics** ( $T_j=25^\circ\text{C}$  unless otherwise specified)



## BZX55B Series

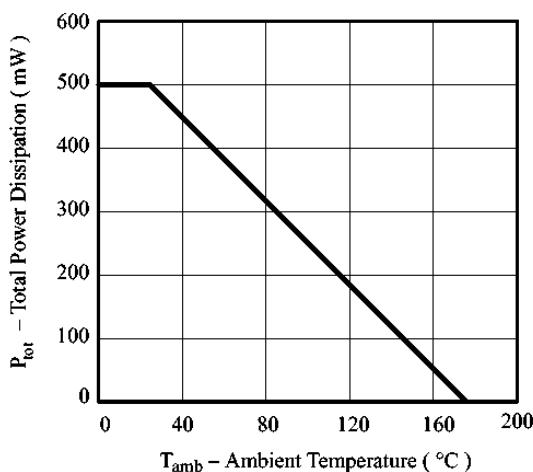


Figure 1. Total Power Dissipation vs.  
Ambient Temperature

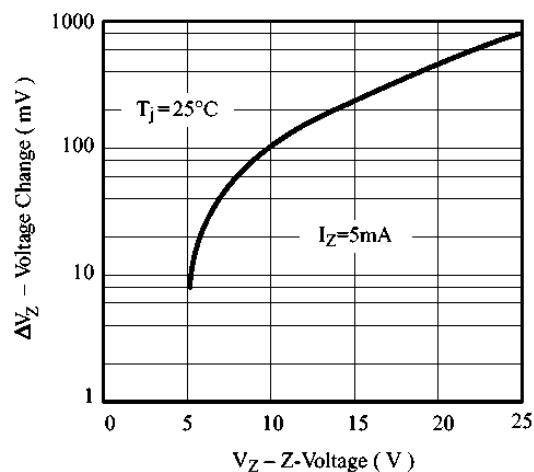


Figure 2. Typical Change of Working Voltage  
under Operating Conditions at  $T_{\text{amb}}=25^\circ\text{C}$

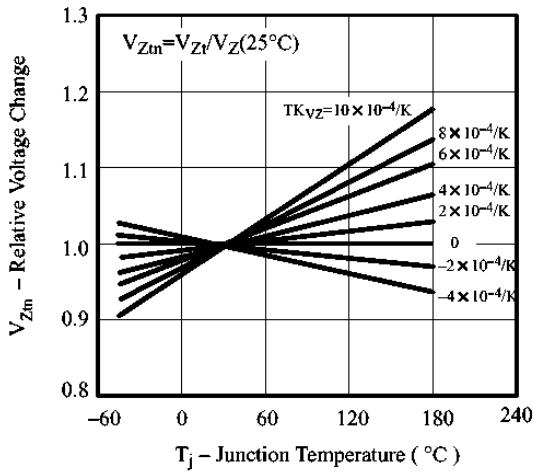


Figure 3. Typical Change of Working Voltage vs.  
Junction Temperature

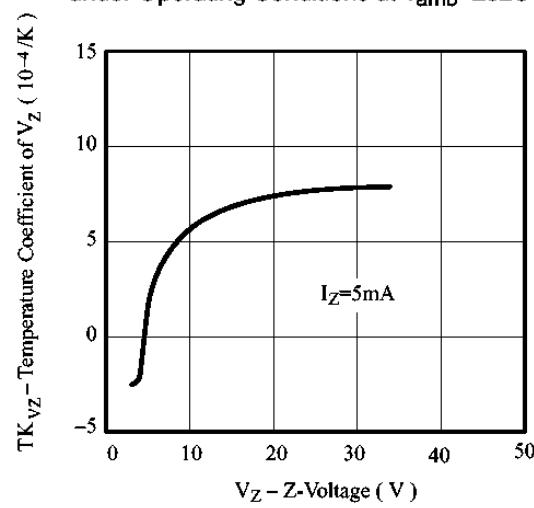


Figure 4. Temperature Coefficient of  $V_Z$  vs.  
 $Z$ -Voltage

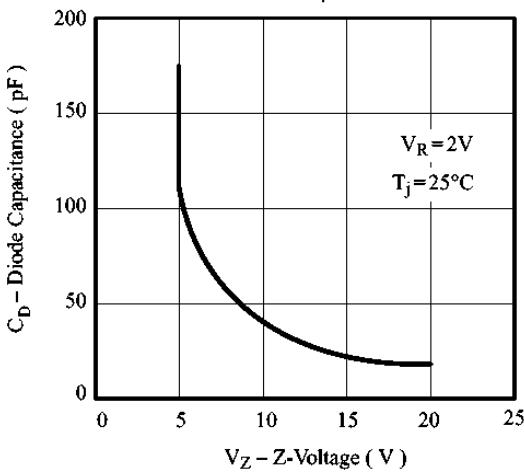


Figure 5. Diode Capacitance vs. Z-Voltage



## BZX55B Series

